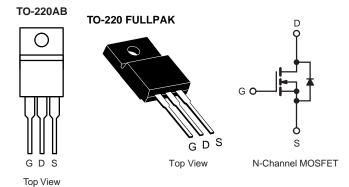


# N-Channel 60 V (D-S) MOSFET

PRODU	CT SUMMARY		
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)
	0.027 at V <sub>GS</sub> = 10 V	55	
60	0.029 at V <sub>GS</sub> = 6 V	55	27.5 nC
	0.030 at V <sub>GS</sub> = 4.5 V	50	



## **FEATURES**

- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested
   Low Q<sub>g</sub> for High Efficiency



## **APPLICATIONS**

- Primary Side Switch
- POL
- Synchronous Rectifier
- DC/DC Converter
- Amusement System
- Industrial
- LED Backlighting

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_{C} = 25 \text{ °C}$ $T_{C} = 70 \text{ °C}$ $T_{A} = 25 \text{ °C}$ $T_{A} = 70 \text{ °C}$	I <sub>D</sub>	55 <sup>a</sup> 55 <sup>a</sup> 35.8 <sup>b, c</sup> 28.6 <sup>b, c</sup>	A	
Pulsed Drain Current (60 µs Pulse Width)		I <sub>DM</sub>	350	A	
Continuous Source-Drain Diode Current $ T_{C} = 25  ^{\circ}\text{C} $ $ T_{A} = 25  ^{\circ}\text{C} $		Is	55 <sup>a</sup> 5.6 <sup>b, c</sup>		
Single Pulse Avalanche Current  L = 0.1 mH		I <sub>AS</sub>	40		
Single Pulse Avalanche Energy	L = 0.111111	E <sub>AS</sub>	80	mJ	
	T <sub>C</sub> = 25 °C		104	W	
Maximum Power Dissipation	$T_C = 70  ^{\circ}C$	P <sub>D</sub>	66.6		
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	' D	6.25 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		4 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature)			260		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient	t ≤ 10 s	R <sub>thJA</sub>	15	20	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	0.9	1.2	C/VV

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	60			V
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I <sub>D</sub> = 250 μA		- 6		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1		3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Cata Valtana Busin Comunit	1 .	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V	1		4	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α
	) /	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.027	0.030	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 6 \text{ V}, I_D = 20 \text{ A}$		0.029	0.032	Ω
	, ,	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.030	0.034	1
Forward Transconductance <sup>a</sup>				82		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			1475		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		305		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			77		
Total Cata Charge	Qg	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		63.5	96	
Total Gate Charge				27.5	42	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		12		nC
Gate-Drain Charge	$Q_{gd}$			5.9		
Gate Resistance	$R_{g}$	f = 1 MHz	0.4	1.2	2.4	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			14	28	
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 3 \Omega$		11	22	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		33	60	
Fall Time	t <sub>f</sub>			11	22	
Turn-On Delay Time	t <sub>d(on)</sub>			47	90	ns -
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 3 \Omega$		97	180	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		32	60	
Fall Time	t <sub>f</sub>			13	26	
<b>Drain-Source Body Diode Characteristi</b>	cs					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			60	۸
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				100	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.73	1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			79	120	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 10 A dl/dt = 100 A/vo T = 25 °C		88	135	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		32		20
Reverse Recovery Rise Time t <sub>b</sub>				47		ns

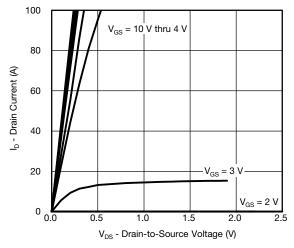
### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

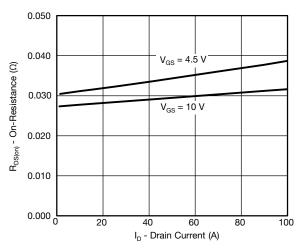
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

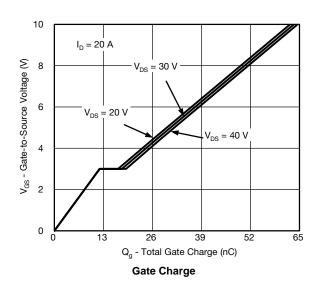
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

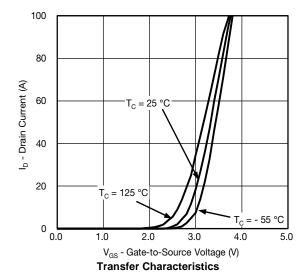


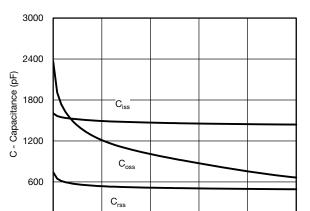
# **Output Characteristics**



### On-Resistance vs. Drain Current and Gate Voltage







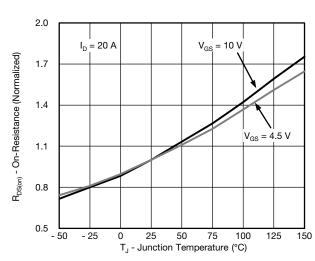
24

0

12

V<sub>DS</sub> - Drain-to-Source Voltage (V) Capacitance

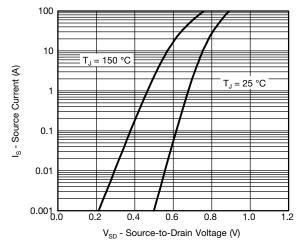
36



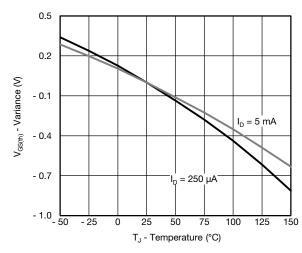
On-Resistance vs. Junction Temperature

60

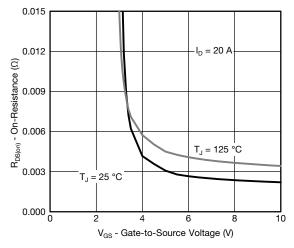
# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



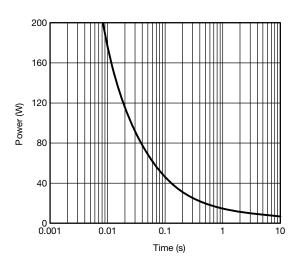
## Source-Drain Diode Forward Voltage



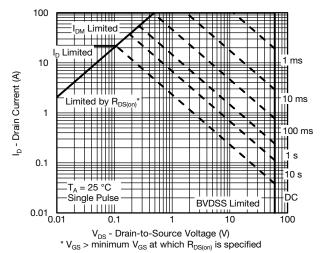
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage

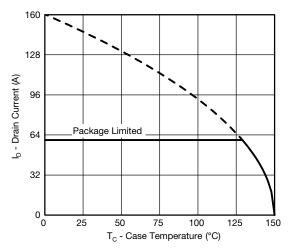


Single Pulse Power, Junction-to-Ambient

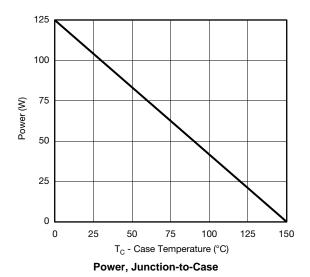


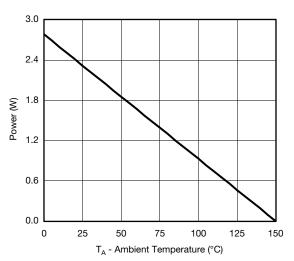
Safe Operating Area, Junction-to-Ambient

# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***



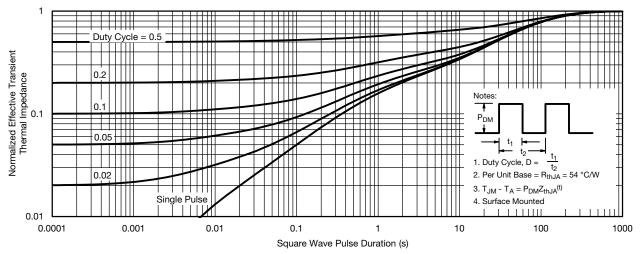


Power, Junction-to-Ambient

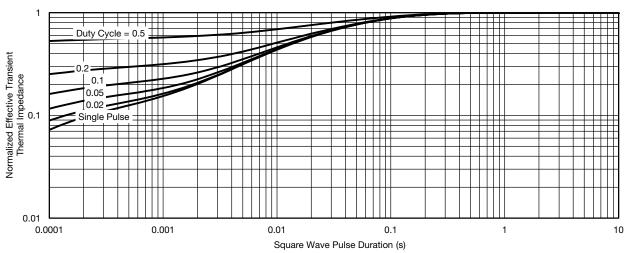
 $<sup>^*</sup>$  The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



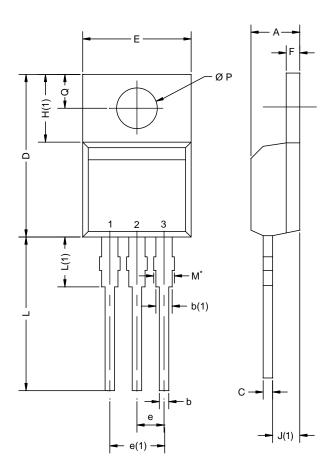
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-220AB**



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0 DWG: 5471	)208-Rev. N,	08-Oct-12			

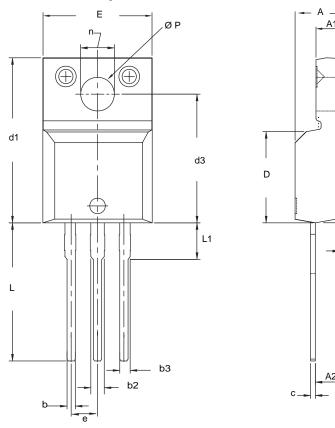
### Notes

 $<sup>^{*}</sup>$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM





# **TO-220 FULLPAK (HIGH VOLTAGE)**



	MILLIMETERS		INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100 BSC	
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØΡ	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	0.098
V	0.400	0.500	0.016	0.020

DWG: 5972

- To be used only for process drawing.
   These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
   All critical dimensions should C meet C<sub>pk</sub> > 1.33.
   All dimensions include burrs and plating thickness.
   No chipping or package damage.





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